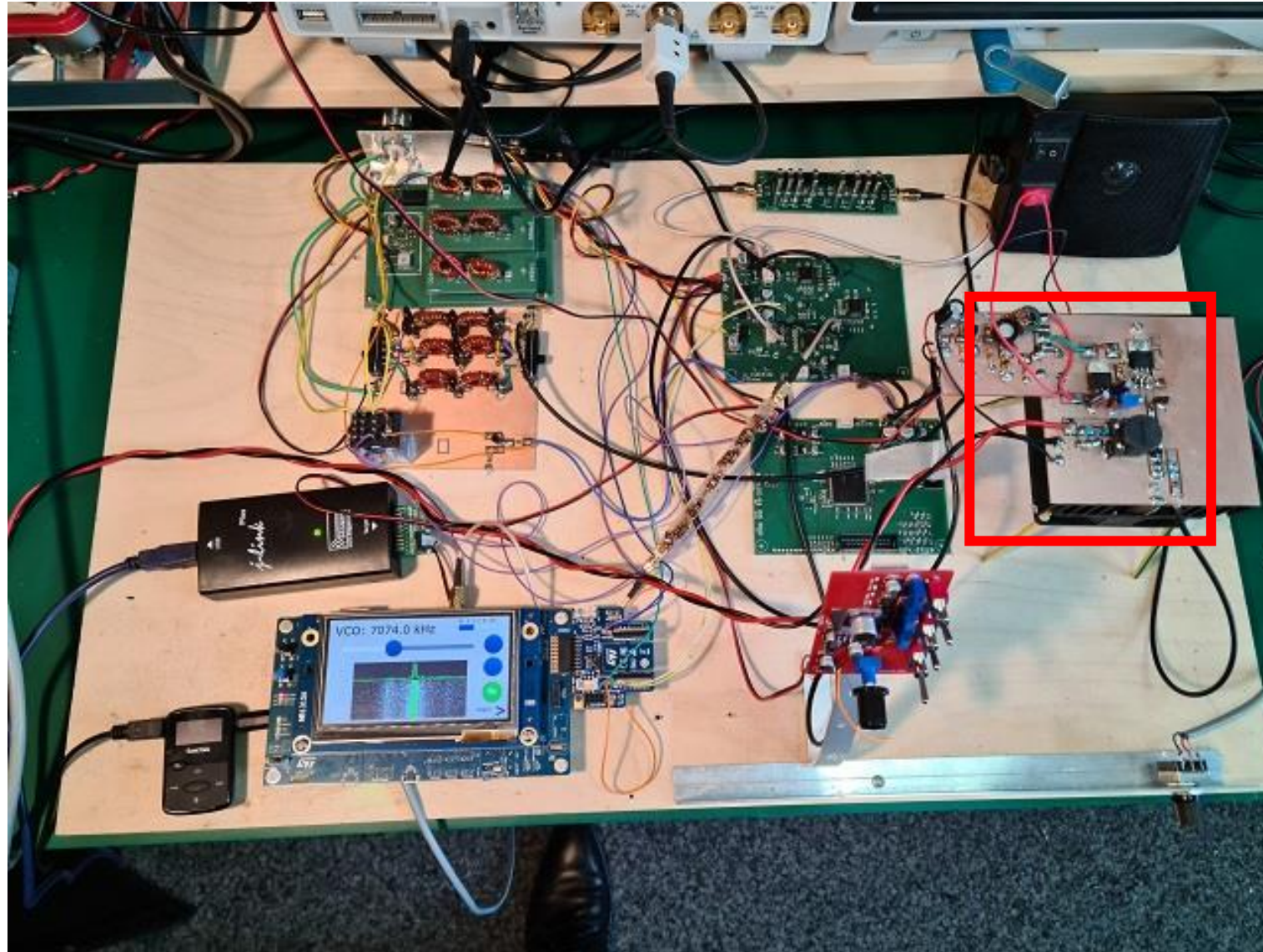
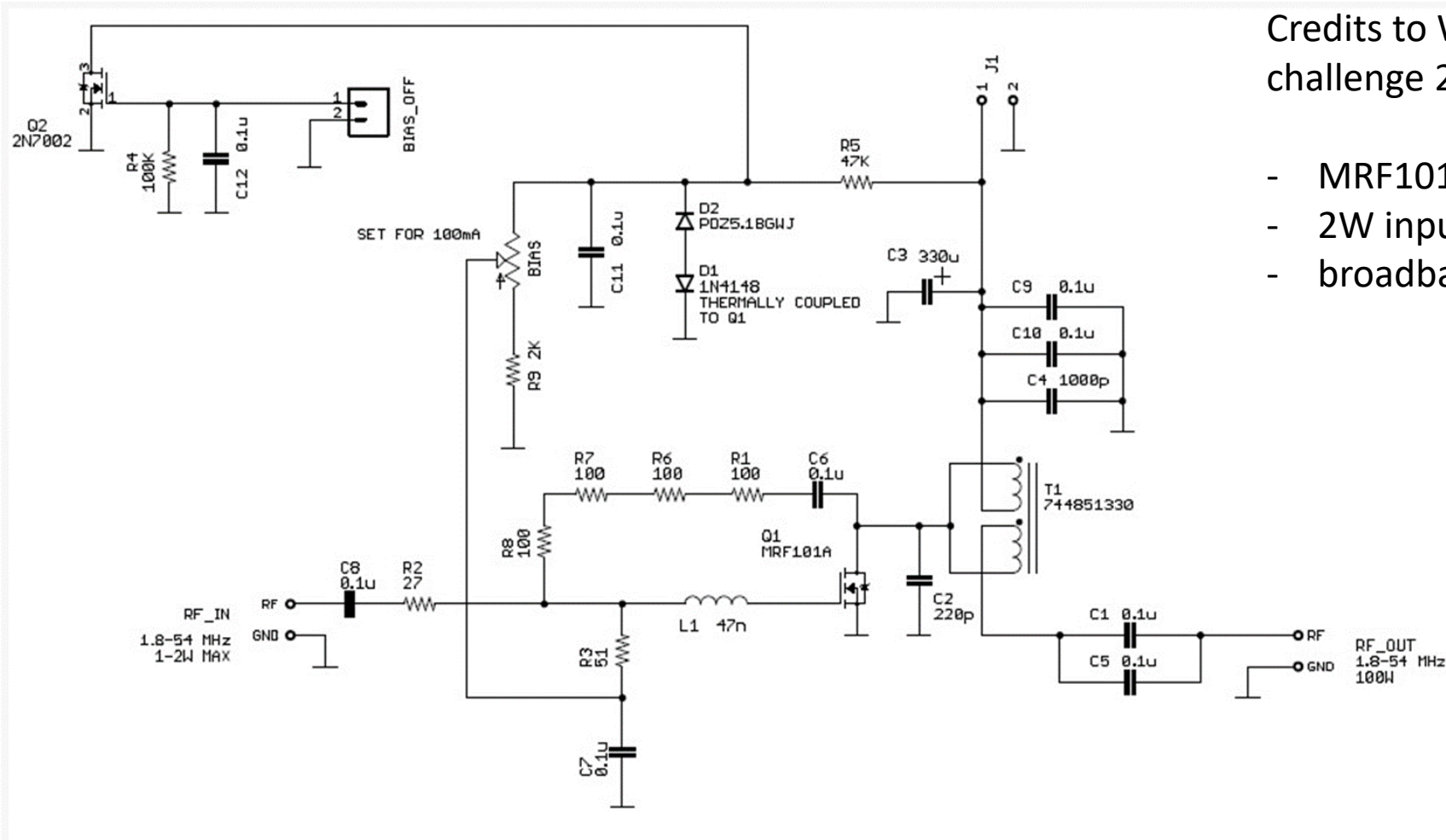


# Design Power-Amplifier



# Amplifier Design by Jim, WA2EUJ

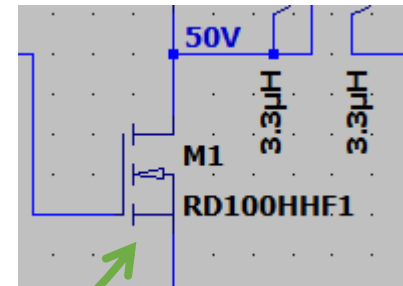
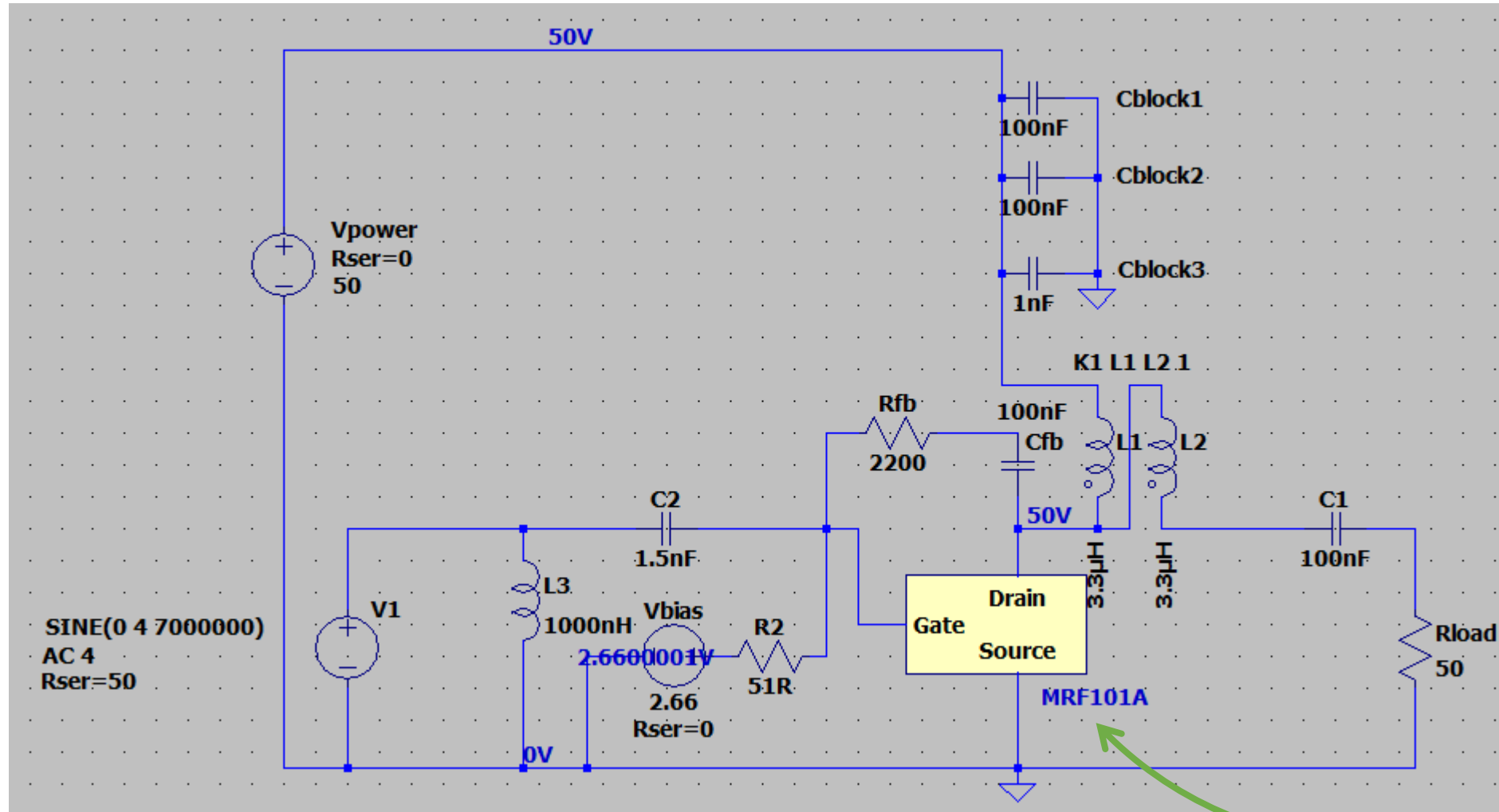


Credits to WA2EUJ who won the NXP design challenge 2019!

- MRF101 LDMOS (25\$/p)
- 2W input / 100W output → 17dB
- broadband

<https://sites.google.com/site/rfpowertools/rf-power-tools/nxp-mrf-101>

# Amplifier simulation LTSpice



# The LTSpice simulation challenge

NXP Semiconductors  
Technical Data

Document Number: MRF101AN  
Rev. 1.05/019

**RF Power LDMOS Transistors**  
High Ruggedness N-Channel  
Enhancement-Mode Lateral MOSFETs

These devices are designed for use in HF and VHF communications, industrial, scientific and medical (ISM) and broadcast and aerospace applications. The devices are extremely rugged and exhibit high performance up to 250 MHz.

Typical Performance:  $V_{DD} = 50$  Volts

| Frequency (MHz) | Signal Type                         | $P_{out}$ (W) | $P_{eff}$ (dB) | $\eta_{eff}$ (%) | $\Delta f$ (Hz) |
|-----------------|-------------------------------------|---------------|----------------|------------------|-----------------|
| 13.56 MHz       | CW                                  | 130 CW        | 27.1           | 79.6             |                 |
| 27 MHz          | CW                                  | 120 CW        | 26.9           | 79.6             |                 |
| 40.68 MHz       | CW                                  | 120 CW        | 23.8           | 81.3             |                 |
| 50 MHz          | CW                                  | 110 CW        | 23.8           | 82.1             |                 |
| 81.25 MHz       | CW                                  | 120 CW        | 23.2           | 80.9             |                 |
| 17.5-132 MHz    | CW                                  | 110 CW        | 20.6           | 78.9             |                 |
| 130-230 MHz     | CW                                  | 100 CW        | 21.2           | 78.5             |                 |
| 230 MHz         | Pulse (100 $\mu$ s, 20% Duty Cycle) | 110 Peak      | 21.1           | 78.7             |                 |

Load Mismatch Ruggedness

| Frequency (MHz) | Signal Type                         | VSWR                      | $P_{out}$ (W)             | Test Voltage | Result                |
|-----------------|-------------------------------------|---------------------------|---------------------------|--------------|-----------------------|
| 40.68           | CW                                  | > 6:1 at all Phase Angles | 0.64 CW                   | 50           | No Device Degradation |
| 230             | Pulse (100 $\mu$ s, 20% Duty Cycle) | > 6:1 at all Phase Angles | 1.8 Peak (5 dB Overdrive) | 50           | No Device Degradation |

1. Measured in 13.56 MHz reference circuit (page 15).  
2. Measured in 27 MHz reference circuit (page 15).  
3. Measured in 40.68 MHz reference circuit (page 15).  
4. Measured in 50 MHz reference circuit (page 21).  
5. Measured in 81.25 MHz broadband reference circuit (page 25).  
6. Measured in 130-230 MHz broadband reference circuit (page 25).  
7. The values shown are the lower band performance numbers across the indicated frequency range.  
8. Measured in 130-174 MHz VHF broadband reference circuit (page 30).  
9. Measured in 230 MHz reference circuit (page 36).


Features

- Minor process versions (A and B) to simplify use in a push-pull, two-up configuration.
- Characterized from 30 to 300 V.
- Suitable for linear application.
- Integrated ESD protection with greater negative gate-source voltage range for improved Class C operation.
- Included in NXP product longevity program with assured supply for a minimum of 10 years after launch.

Typical Applications

- Industrial, scientific, medical (ISM)
- Radio and VHF TV broadcast
- Laser generation
- HF and VHF communications
- Plasma excitation
- RF and VHF power supplies
- Particle accelerators
- Switch mode power supplies
- Industrial heating, welding and drying systems

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No LTSpice Model; not even for LDMOS (only VDMOS)  
NXP provides only S-Parameters.

! Copyright - 2018 NXP B.V.

! 11/29/2018

! Rev 0

! MRF101AN/BN S-Parameters

! Vdd=50V, IDQ=1000mA

# hz S ma R 50

! Comment

! freq magS11 angS11 magS21 angS21 magS12 angS12 magS22 angS22

!

|          |             |             |            |            |               |            |             |             |
|----------|-------------|-------------|------------|------------|---------------|------------|-------------|-------------|
| 30000000 | 0.564235448 | -99.7043106 | 53.2145653 | 102.23512  | 0.00547553021 | 28.7605559 | 0.416624089 | -97.7164457 |
| 35000000 | 0.572121868 | -105.443103 | 46.8439683 | 98.2792741 | 0.00622285213 | 18.0655717 | 0.416214496 | -102.203608 |
| 40000000 | 0.585444096 | -109.745584 | 41.8694627 | 95.6498936 | 0.0059789161  | 15.4206392 | 0.42123798  | -105.432068 |

On groups.io "LTSpice" you find a tool to convert a S-Parameter file (touchstone) into a .subckt spice model/library:

[https://groups.io/g/LTSpice/files/z\\_yahoo/Tut/S-Parameter/S-Parameter%20to%20SPICE/s2spice.exe](https://groups.io/g/LTSpice/files/z_yahoo/Tut/S-Parameter/S-Parameter%20to%20SPICE/s2spice.exe)

(added manually S-Parameters for 3 MHz)

```
.SUBCKT MRF101A 1 2 3
* Copyright - 2018 NXP B.V.
* 11/29/2018
* Rev 0
* MRF101AN/BN S-Parameters
* Vdd=50V, IDQ=1000mA
* hz S ma R 50
* Comment
* freq magS11 angS11 magS21 angS21 magS12 angS12 magS22 angS22
*
* Z1=50.000000 Z2=50.000000
```

```
R1N 1 10 -5.000000e+001
R1P 10 11 1.000000e+002
R2N 2 20 -5.000000e+001
R2P 20 21 1.000000e+002
```

```
*S11 FREQ MAG PHASE
E11 11 12 FREQ {V(10,3)}= MAG
+( 1.000000e+006, 5.642354e-001, -9.970431e+001)
+( 3.000000e+007, 5.642354e-001, -9.970431e+001)
+( 3.500000e+007, 5.721219e-001, -1.054431e+002)
```

.lib file

.ac worked well; .trans did not work at all...

## LDMOS vs. GaN

**LDMOS (laterally-diffused metal-oxide semiconductor)** is a planar double-diffused [MOSFET](#) (metal–oxide–semiconductor field-effect transistor).

- used in RF power amps in e.g. mobile networks (2G, 5G)
- High power, linear, high efficiency
- 1MHz up to 3.5GHz
- drain – source breakdown >60V typically

**GaN** (gallium nitride) power amplifiers:

- 10% higher efficiency (smaller output capacitance, easier to build wideband applications), higher frequencies, higher break down voltage and easier to linearize...

# Impedance matching

## 13.56 MHz COMPACT REFERENCE CIRCUIT (MRF101AN)

| f (MHz) | Z <sub>source</sub> (Ω) | Z <sub>load</sub> (Ω) |
|---------|-------------------------|-----------------------|
| 13.56   | 25.3 + j10.2            | 11.3 - j6.4           |

Z<sub>source</sub> = Test circuit impedance as measured from gate to ground.

Z<sub>load</sub> = Test circuit impedance as measured from drain to ground.

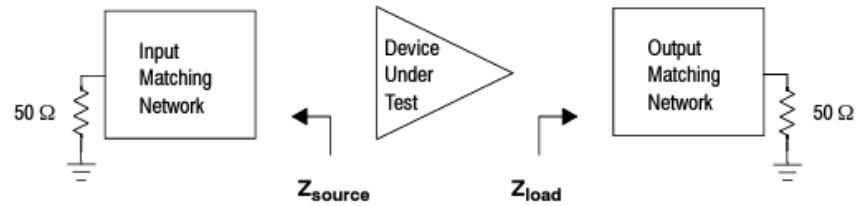



Figure 8. Series Equivalent Source and Load Impedance — 13.56 MHz

  
 $25 - j10$

## Matching Network Designer

**Set Source Impedance (Zs)**

Zs Source Scalar Complex Impedance ▼

Impedance (Ohms)

**Set Load Impedance (Zl)**

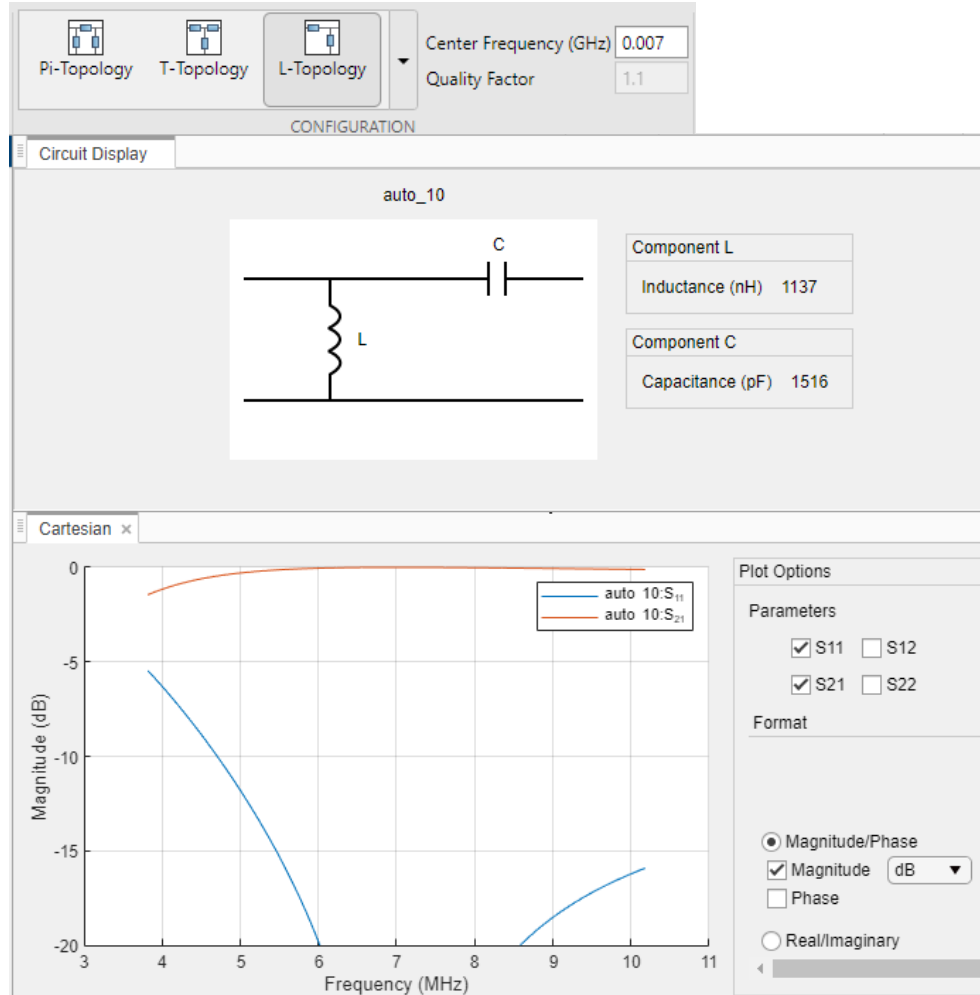
Zl Load Scalar Complex Impedance ▼

Impedance (Ohms)

Center Frequency

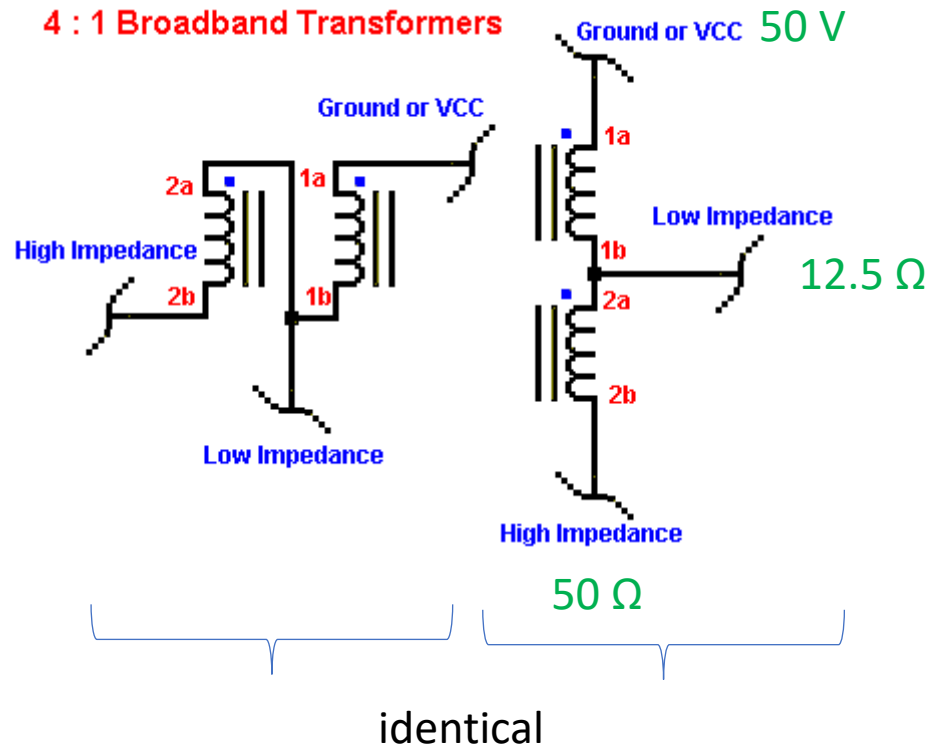
Bandwidth

# Input-Impedance matching





# Output-Impedance matching

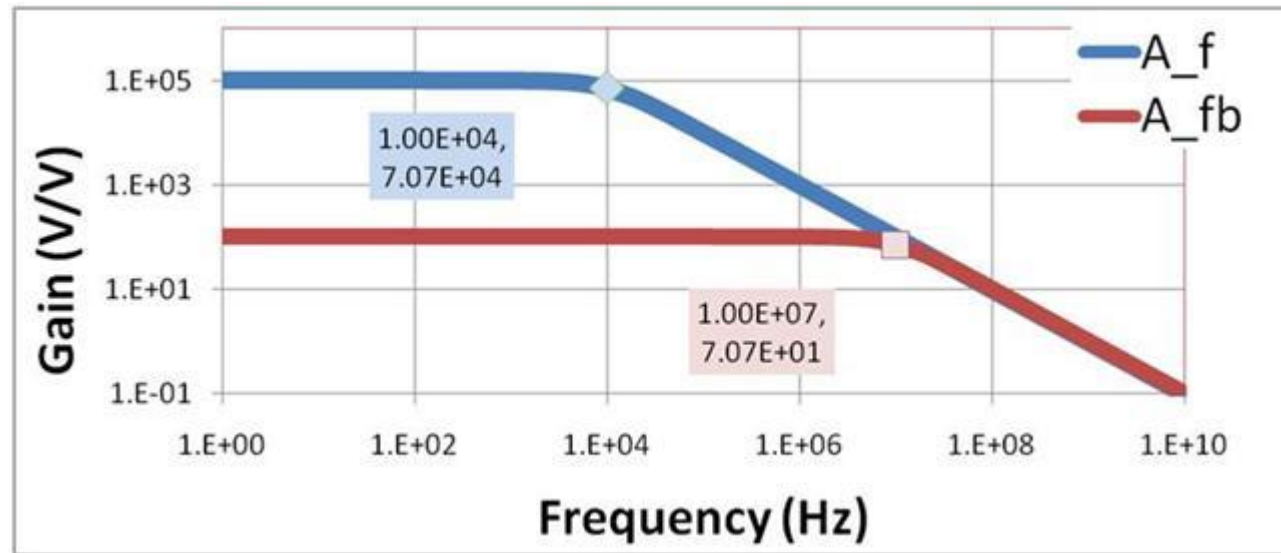
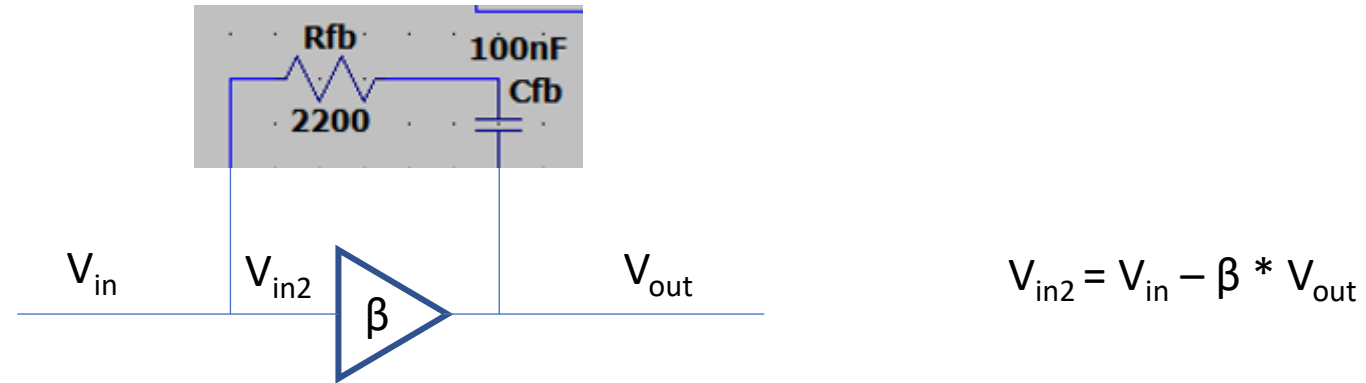


$$Z_{\text{target}}: 11 \Omega - j6 \Omega \rightarrow |Z_{\text{target}}| = 12.5 \Omega$$

Transmission-Line-Transformer; symmetrical



# Providing negative feedback



[https://en.wikipedia.org/wiki/Negative-feedback\\_amplifier](https://en.wikipedia.org/wiki/Negative-feedback_amplifier)

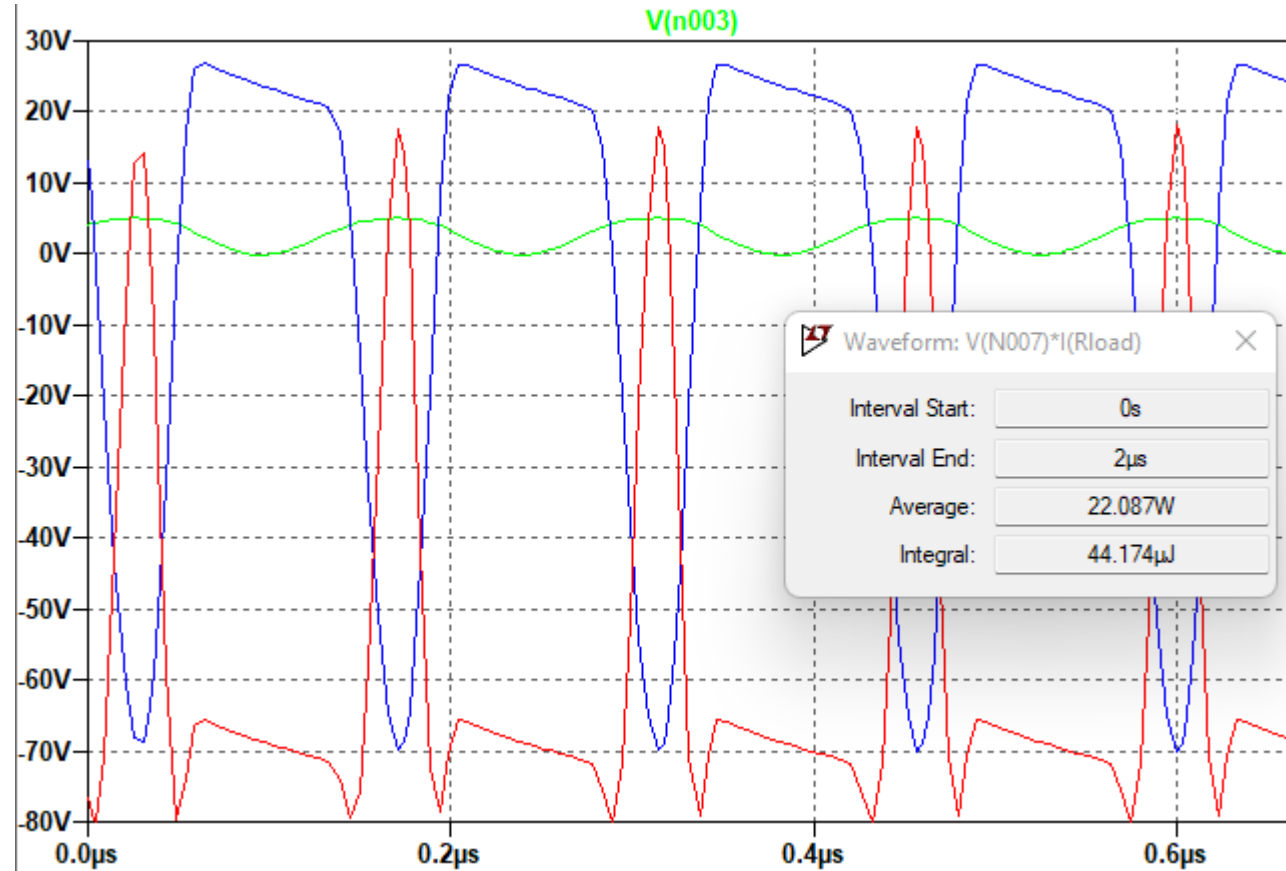
# Simulation results LTSpice

$V_{in} = 10V_{pp}, 7MHz$

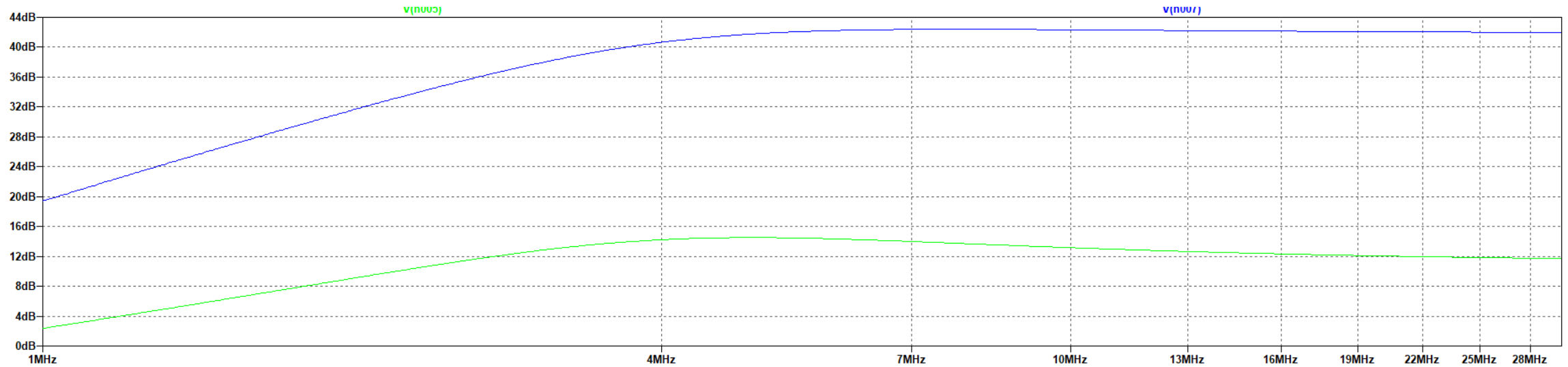
green =  $V_{GS}$

blue =  $v_{load(50)}$

red =  $p(t) @ load(50)$



# Simulation results LTSpice



Vin = 10Vpp, 7MHz

gain of about 30dB

green =  $V_{in}$

blue =  $V_{load(50)}$

But: no S-Parameters down to 1 MHz!!